DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE	SERIAL NO. 10/644,257	ATTY DOCKET NO. AP172HO
	APPLICANT Wai Yim, et al.	
INFORMATION DISCLOSURE CITATION (USE SEVERAL SHEETS IF NECESSARY) PAGE 1 OF 1	FILING DATE August 20, 2003	GROUP 2173

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U.S. PATENT DOCUMENTS

E.I.		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE
WT	AA	2003/0145023	7/31/03	Bennett, Jr., et al.			
WT	AB	6,369,835	4/9/02	Lin			
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

FOREIGN PATENT DOCUMENTS

E.I.		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION
	AL						
	AM						
	AN						
	AO						
	AP						
	AQ						

OTHER DOCUMENTS (INCLUDING AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.)

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U.S. PATENT DOCUMENTS

E.I.		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE
WT	AA	2002/0085029 A1	July 4, 2002	Ghani			
WT	AB	2002/0085030 A1	July 4, 2002	Ghani			
WT	AC	2002/0087592 A1	July 4, 2002	Ghani			
WT	AD	2002/0120939 A1	August 29, 2002	Wall, et al.			
WT	AE	2002/0122075 A1	September 5, 2002	Karasawa et al.			
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

FOREIGN PATENT DOCUMENTS

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	AL						
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